FORM PTO 1449 (modif	fied)		ATTY DOCKET NO. 25 C15729	APPLICATION NO. 09/940,643					
U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			35.C15729 09/940,643 APPLICANT SHIN KITAMURA ET AL.						
LIST OF REFERENCES CITED BY APPLICANTS) (Use several sheets if necessary) Date Submitted to PTO:[DATE]			FILING DATE AUGUST 29, 2001		GROUP 2879				
Date Submitted to 7 10	NOV Z	8 5001 H	U.S. PATENT DOCUMENTS						
*EXAMINER INITIAL	DOCUMENT NUMBER		NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE			
AN	4,904,895	2/90	Tsukamoto et al.	313	336				
	5,986,389	11/99	Tsukamoto	313	309				
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AN	0 614 209 A1	9/94	EPO						
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AN	8-115652	5/96	JAPAN			ABSTRACT			
AN	7-6714	1/95	JAPAN						
	от	HER DOCUME	NT(S) (Including Author, Title, Date	e, Pertinent Pages, Etc.)		A d = b · b · d = · · · · · ·			
AN	C.A. Spindt et al., Physical Properties of thin-Film Field Emission Cathodes with Molybdenum Cones, Journal of Applied Physics, Vol. 47, No. 12 (1976) pp.5248-5263								
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^{*}EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and considered. Include copy of this form with next communication to applicant.

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				U.S. PATENT DOCUMENTS		<u> </u>		
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